
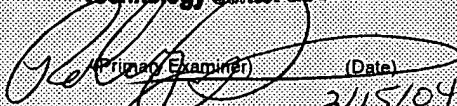


Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/649,085		CHEN, SEAN S.	
	Examiner		Art Unit	
	Joseph Chang		2817	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
311		111		143	185	173			
INTERNATIONAL CLASSIFICATION									
H	0	3	L	7/00					
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				/					
Joseph Chang (Assistant Examiner) (Date)					Robert Pascal Supervisory Patent Examiner Technology Center 2800 (Primary Examiner) (Date)			Total Claims Allowed: 17	
Hayes 2-18-05 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. 2

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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